## Notice of References Cited Application/Control No. 10/687,379 Examiner John B. Sotomayor Applicant(s)/Patent Under Reexamination POE ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Х	Α	US-5,629,706 A	05-1997	Baath, Lars	342/124
Х	В	US-2002/0063622 A1	05-2002	Armstrong et al.	340/10.31
Х	С	US-2002/0140597 A1	10-2002	Taylor et al.	342/28
Х	D	US-2002/0175805 A9	11-2002	Armstrong et al.	340/10.31
Х	Ε	US-2004/0056794 A1	03-2004	Erkocevic-Pribic, Radmila	342/196
	F	US-			
	G	US-			
	Η	US-			
	_	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ					
	O					
	R					
	S					
	Т		(7)			

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	"Analysis of terrain scattered interference-mitigation", Nelander, A.;Radar Conference, 2004. Proceedings of the IEEE , 26-29 April 2004 Pages:414 - 419
	٧	"Measurement of S band clutter statistics using quasi-deconvolution filter for a phase coded waveform", LeFurjah, G.; Foreman T.; Boyer, Dd.B.;Radar Conference, 2003. Proceedings of the 2003 IEEE, 5-8 May 2003 Pages:34 - 37
	w	"Potentials of ultra-short-pulse time-domain scattering measurements", Van Cappellen, W.A.; de Jongh, R.V.; Ligthart, L.P.;Antennas and Propagation Magazine, IEEE, Volume: 42, Issue: 4, Aug. 2000 Pages:35 - 45
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707,05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.